

**Search Notes (continued)**


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Examiner

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 Applicant(s)/Patent under  
Reexamination

WIERENGA ET AL.

Art Unit

3752

**SEARCHED**

Class	Subclass	Date	Examiner
updated	SEARCHED	1/15/08	DN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR